

Search Notes

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Examiner

John D. Lee

Applicant(s)/Patent under
Reexamination

KAWANISHI ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
359	326-332	1/11/2006	JDL
	(Updated)		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Previous USPTO "WEST" Database search updated (same search terms)	1/11/2006	JDL